Preferred Device

Sensitive Gate Triacs

Silicon Bidirectional Thyristors

Designed for industrial and consumer applications for full wave control of ac loads such as appliance controls, heater controls, motor controls, and other power switching applications.

- Sensitive Gate Allows Triggering by Microcontrollers and other Logic Circuits
- Uniform Gate Trigger Currents in Three Quadrants; Q1, Q2, and Q3
- High Immunity to dv/dt 25 V/μs Minimum at 110°C
- High Commutating di/dt 8.0 A/ms Minimum at 110°C
- Minimum and Maximum Values of IGT, VGT and IH Specified for Ease of Design
- On-State Current Rating of 8 Amperes RMS at 70°C
- High Surge Current Capability 70 Amperes
- Blocking Voltage to 800 Volts
- Rugged, Economical TO220AB Package
- Device Marking: Logo, Device Type, e.g., MAC8SM, Date Code

MAXIMUM RATINGS (T_{.J} = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Peak Repetitive Off–State Voltage ⁽¹⁾ (T _J = -40 to 110°C, Sine Wave, 50 to 60 Hz, Gate Open)	V _{DRM,} V _{RRM}		Volts
MAC8SD MAC8SM MAC8SN		400 600 800	
On-State RMS Current (Full Cycle Sine Wave, 60 Hz, T _C = 70°C)	lT(RMS)	8.0	Amps
Peak Non-Repetitive Surge Current (One Full Cycle Sine Wave, 60 Hz, T _J = 110°C)	ITSM	70	Amps
Circuit Fusing Consideration (t = 8.3 ms)	I ² t	20	A ² sec
Peak Gate Power (Pulse Width ≤ 1.0 μs, T _C = 70°C)	Рдм	16	Watts
Average Gate Power (t = 8.3 ms, T _C = 70°C)	P _G (AV)	0.35	Watt
Operating Junction Temperature Range	TJ	-40 to +110	°C
Storage Temperature Range	T _{stg}	-40 to +150	°C

⁽¹⁾ VDRM and VRRM for all types can be applied on a continuous basis. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the devices are exceeded.

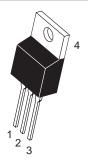


ON Semiconductor

http://onsemi.com

TRIACS 8 AMPERES RMS 400 thru 800 VOLTS





TO-220AB CASE 221A STYLE 4

PIN ASSIGNMENT			
1	Main Terminal 1		
2	Main Terminal 2		
3	Gate		
4	Main Terminal 2		

ORDERING INFORMATION

Device	Package	Shipping
MAC8SD	TO220AB	50 Units/Rail
MAC8SM	TO220AB	50 Units/Rail
MAC8SN	TO220AB	50 Units/Rail

Preferred devices are recommended choices for future use and best overall value.

THERMAL CHARACTERISTICS

Characteristic	Symbol	Value	Unit
Thermal Resistance — Junction to Case — Junction to Ambient	R _Ð JC R _Ð JA	2.2 62.5	°C/W
Maximum Lead Temperature for Soldering Purposes 1/8" from Case for 10 Seconds	TL	260	°C

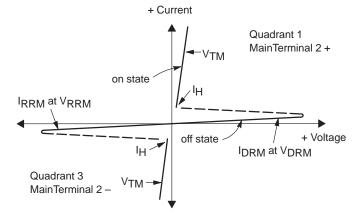
ELECTRICAL CHARACTERISTICS (T_{.J} = 25°C unless otherwise noted; Electricals apply in both directions)

Characteristic	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS					
Peak Repetitive Blocking Current (V_D = Rated V_{DRM} , V_{RRM} ; Gate Open) $T_J = 25^{\circ}C$ $T_J = 110^{\circ}C$	I _{DRM} , I _{RRM}	_ _	_ _	0.01 2.0	mA
ON CHARACTERISTICS			•		
Peak On-State Voltage* (I _{TM} = ±11A)	VTM	_	_	1.85	Volts
Gate Trigger Current (Continuous dc) (V_D = 12 V , R_L = 100 Ω) MT2(+), G(+) MT2(+), G(-) MT2(-), G(-)	lGT	.8 .8 .8	2.0 3.0 3.0	5.0 5.0 5.0	mA
Holding Current (V _D = 12V, Gate Open, Initiating Current = ±150mA)	lΗ	1.0	3.0	10	mA
Latching Current ($V_D = 24V$, $I_G = 5mA$) MT2(+), G(+) MT2(-), G(-) MT2(+), G(-)		2.0 2.0 2.0	5.0 10 5.0	15 20 15	mA
Gate Trigger Voltage (Continuous dc) (V_D = 12 V, R_L = 100 Ω) MT2(+), G(+) MT2(+), G(-) MT2(-), G(-)	V _{GT}	0.45 0.45 0.45	0.62 0.60 0.65	1.5 1.5 1.5	Volts
DYNAMIC CHARACTERISTICS			•	•	•
Rate of Change of Commutating Current VD = 400 V, ITM = 3.5 A, Commutating dv/dt = 10 V μ /sec, Gate Open, TJ = 110°C, f = 500 Hz, Snubber: CS = 0.01 μ F, RS =15 Ω , See Figure 16.)	di/dt(c)	8.0	10	_	A/ms
Critical Rate of Rise of Off-State Voltage (V_D = Rate V_{DRM} , Exponential Waveform, R_{GK} = 510 Ω , T_J = 110 $^{\circ}$ C)	dv/dt	25	75	_	V/μs

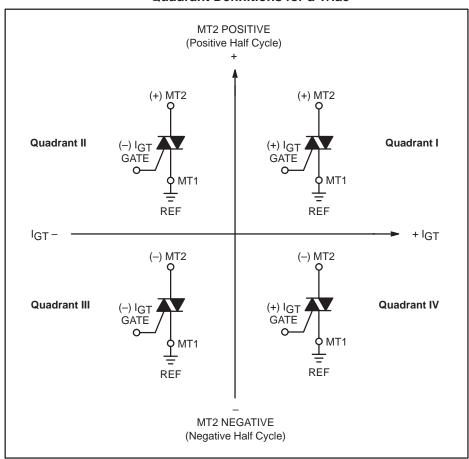
^{*}Indicates Pulse Test: Pulse Width \leq 2.0 ms, Duty Cycle \leq 2%.

Voltage Current Characteristic of Triacs (Bidirectional Device)

	*
Symbol	Parameter
V _{DRM}	Peak Repetitive Forward Off State Voltage
IDRM	Peak Forward Blocking Current
VRRM	Peak Repetitive Reverse Off State Voltage
IRRM	Peak Reverse Blocking Current
V_{TM}	Maximum On State Voltage
lΗ	Holding Current

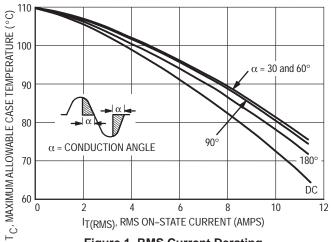


Quadrant Definitions for a Triac



All polarities are referenced to MT1.

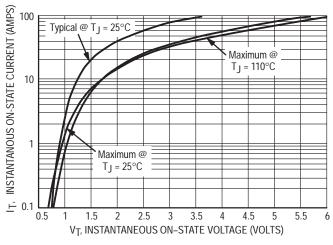
With in-phase signals (using standard AC lines) quadrants I and III are used.



SET THE MALE OF T

Figure 1. RMS Current Derating

Figure 2. Maximum On-State Power Dissipation



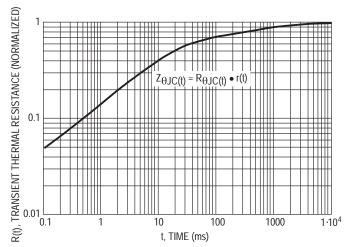
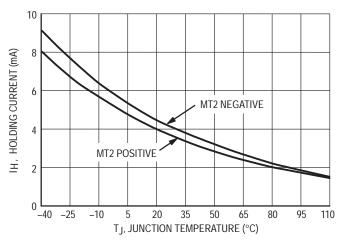


Figure 3. On-State Characteristics

Figure 4. Transient Thermal Response



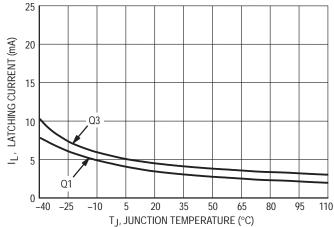


Figure 5. Typical Holding Current Versus
Junction Temperature

Figure 6. Typical Latching Current Versus Junction Temperature

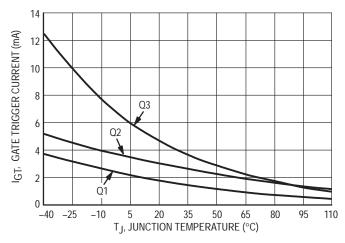


Figure 7. Typical Gate Trigger Current Versus
Junction Temperature

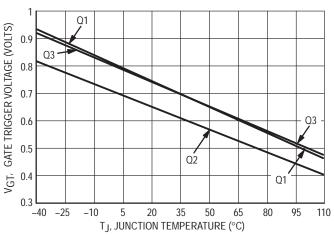


Figure 8. Typical Gate Trigger Voltage Versus

Junction Temperature

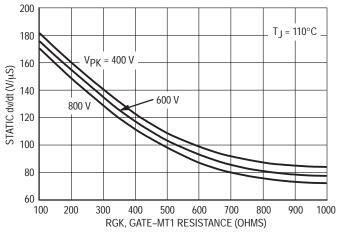


Figure 9. Typical Exponential Static dv/dt Versus Gate–MT1 Resistance, MT2(+)

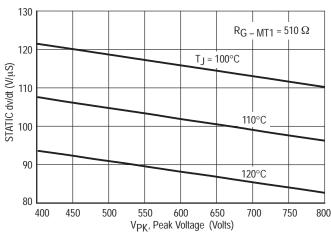


Figure 10. Typical Exponential Static dv/dt Versus Peak Voltage, MT2(+)

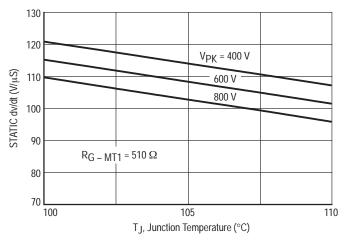


Figure 11. Typical Exponential Static dv/dt Versus Junction Temperature, MT2(+)

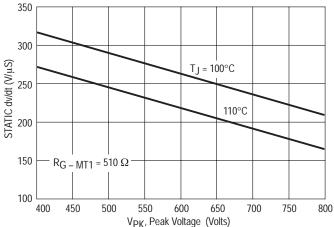


Figure 12. Typical Exponential Static dv/dt Versus Peak Voltage, MT2(-)

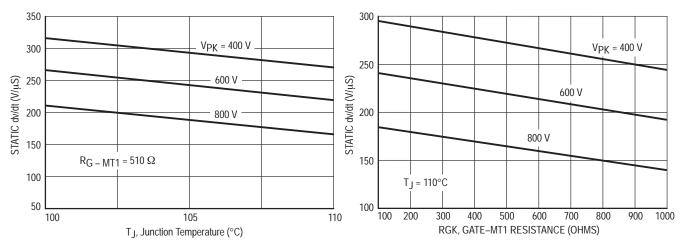
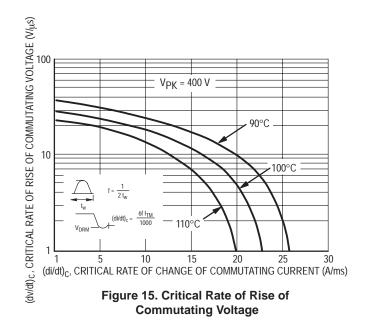


Figure 13. Typical Exponential Static dv/dt Versus Junction Temperature, MT2(–)

Figure 14. Typical Exponential Static dv/dt Versus Gate-MT1 Resistance, MT2(-)



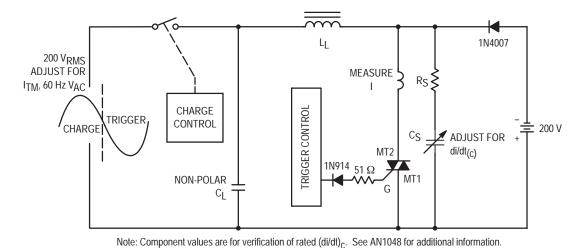
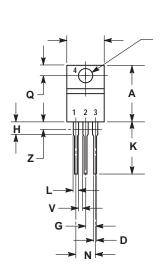
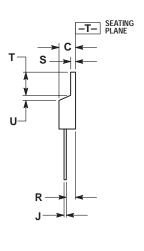


Figure 16. Simplified Test Circuit to Measure the Critical Rate of Rise of Commutating Current (di/dt)_C

PACKAGE DIMENSIONS

TO-220AB CASE 221A-09 **ISSUE Z**





- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.
 3. DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
Α	0.570	0.620	14.48	15.75
В	0.380	0.405	9.66	10.28
С	0.160	0.190	4.07	4.82
D	0.025	0.035	0.64	0.88
F	0.142	0.147	3.61	3.73
G	0.095	0.105	2.42	2.66
Н	0.110	0.155	2.80	3.93
J	0.018	0.025	0.46	0.64
K	0.500	0.562	12.70	14.27
L	0.045	0.060	1.15	1.52
N	0.190	0.210	4.83	5.33
Q	0.100	0.120	2.54	3.04
R	0.080	0.110	2.04	2.79
S	0.045	0.055	1.15	1.39
T	0.235	0.255	5.97	6.47
U	0.000	0.050	0.00	1.27
٧	0.045		1.15	
Z		0.080		2.04

STYLE 4:
PIN 1. MAIN TERMINAL 1
2. MAIN TERMINAL 2
3. GATE
4. MAIN TERMINAL 2

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